Film Metrology & More...

XY-LargePlatform: XY manual platform with 300x200mm traveling distance

XY-LargePlatform is an accessory for FR-pOrtable and FR-pRo tools. It allows the manual thickness & optical properties mapping of large samples fast, easily and accurately.

The platform can be moved manually at any point within an area of 300X200mm and comes with engraved patterns of the standard wafers to facilitate fast characterization of coatings on any wafer or other substrate with dimension up to 300mm.



- Manually controlled
- o Travel range: 300X200mm
- Sample: Dia. 300mm (max)
- Reflectance & Transmittance
- Stage size: 285x205x330mm



The **XY-LargePlatform** is a cost-effective solution for fast characterization of a small number of points of coatings of substrates with large footprint. The platform moves fast and manually and the user can bring under the probe any point of the substrate. It supports (upon request) reflectance and transmittance measurements.